

Application/Control No.

Applicant(s)/Patent under Reexamination

HOCHMUTH ET AL.

Examiner Hau H. Nguyen

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Art Unit 2628

SEARCHED				
Class	Subclass	Date	Examiner	
345	1.1-3.1, 501-503, 519, 520, 53	11/8/2007	н	
	544, 545,			
	555			
178	18.01			
709	201, 203,	·		
	219, 247			
	250			
382	232, 233	11/8/2007	HN	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search (updated)	11/8/2007	HN		
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